

Notice of References Cited	Application/Control No. 10/738,403	Applicant(s)/Patent Under Reexamination VAIDYANATHAN, JANAKIRAMAN	
	Examiner John Wahnkyo Lee	Art Unit 2624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,638,156 A	01-1987	Horikawa et al.	250/235
*	B	US-5,144,685 A	09-1992	Nasar et al.	382/153
*	C	US-5,821,943 A	10-1998	Shashua, Amnon	345/427
*	D	US-5,995,650 A	11-1999	Migdal et al.	382/154
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Park et al., "Dual-beam structured-light scanning for 3-D object modeling," 28 May-1 June 2001, IEEE, pages 65-72□□
	V	Remondino Fabio, "3D Reconstruction of Articulated Objects from Uncalibrated Images," Jan. 2002, SPIE, Vol. 4661, pages 148-154
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.